

**Search Notes**

Application/Control No.

10/056,080

Examiner

Tran Q. Le

Applicant(s)/Patent under  
Reexamination

SHIN-ICHIROU HARASAWA

Art Unit

2633

**SEARCHED**

Class	Subclass	Date	Examiner
398	6,11,18	2/11/2005	TQL
"	23,32,33	2/11/2005	TQL
"	37,38,62	2/11/2005	TQL
"	64,97,157	2/11/2005	TQL
"	160,177	2/11/2005	TQL
359	333-349	2/14/2005	TQL
372	70,71	2/16/2005	TQL
	82,83,88	2/16/2005	TQL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Jason C.	2/11/2005	TQL
Inventor check	2/11/2005	TQL